

Search Notes**Application/Control No.**

10/696,357

Examiner

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Applicant(s)/Patent under Reexamination

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Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	12	1/6/2006	JSL
716	13	1/6/2006	JSL
716	14	1/6/2006	JSL
716	16	1/6/2006	JSL
716	17	1/6/2006	JSL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	1/6/2006	JSL
IEEE	1/6/2006	JSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
716	12	1/6/2006	JSL
716	13,14	1/6/2006	JSL
716	16,17	1/6/2006	JSL